

CLAIMS

Having thus described our invention, what we claim as new, and desire to secure by Letters Patent is:

- 1 1. A dual port SRAM cell comprising six nMOS devices,
2 two nMOS pull-down devices,
3 two nMOS first pair of transfer devices,
4 two nMOS second pair of transfer devices,
5 a first pair of bitlines coupled to the drains of the first pair of transfer
6 devices,
7 a second pair of bitlines coupled to the drains of the second pair of
8 transfer devices,
9 a first wordline coupled to the gates of the first pair of transfer devices,
10 and
11 a second wordline coupled to the gates of the second pair of transfer
12 devices.

- 1 2. The dual port SRAM cell of claim 1, wherein said first pair of
2 transfer gates also serve as the load devices for the SRAM cell.

- 1 3. The dual port SRAM cell of claim 1, wherein said second pair of
2 transfer gates also serve as the load devices for the SRAM cell.

- 1 4. The dual port SRAM cell of claim 1, wherein said first wordline is
2 the first port for read and write operations.

- 1 5. The dual port SRAM cell of claim 1, wherein said second wordline is
2 the second port for read and write operations.

1 6. A dual port SRAM cell comprising four nMOS and three pMOS
2 devices,
3 two nMOS pull-down devices,
4 two pMOS pull-down devices,
5 two nMOS first pair of transfer devices,
6 one pMOS second transfer device,
7 a first pair of bitlines coupled to the drains of the first pair of transfer
8 devices,
9 a second bitline coupled to the drain of the second transfer device,
10 a first wordline coupled to the gates of the first pair of transfer devices,
11 and
12 a second wordline coupled to the gate of the pMOS second transfer
13 device.

1 7. The dual port SRAM cell of claim 6, wherein said first wordline is
2 the first port for read and write operations.

1 8. The dual port SRAM cell of claim 6, wherein said second wordline is
2 the second port for read-only operations.

1 9. A high-speed SRAM architecture comprising:
2 two dual port SRAM blocks,
3 a TAG cache, and
4 an interface circuit.

1 10. The high-speed SRAM architecture of claim 9, wherein a write
2 operation is performed with a first $\frac{1}{2}$ cycle writing data to the first dual port cache, and
3 a second $\frac{1}{2}$ cycle writing data to the second dual port cache via the read-write port.

1 11. The high-speed SRAM architecture of claim 9, wherein a read
2 operation is performed with a first $\frac{1}{2}$ cycle reading data from the first dual port cache,
3 and a second $\frac{1}{2}$ cycle reading data from the second dual port cache via either of the
4 dual ports.

1 12. The high-speed SRAM architecture of claim 9, wherein the
2 addresses of valid data stored in the dual dual-port SRAM cache are stored in the TAG
3 cache, incoming addresses are compared to addresses stored in the TAG and to
4 schedule read and write operations, and when new data is stored in the dual dual-port
5 cache, the status in the TAG cache is updated.